




<b>Search Notes</b> 	<b>Application/Control No.</b> 09927894	<b>Applicant(s)/Patent Under Reexamination</b> JEWETT ET AL.
	<b>Examiner</b> Nano, Sargon N	<b>Art Unit</b> 2157

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Sargon Nano	12/20/06	SN
Conferees:		
Ario-Etienne		
Zarni Maung		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner